

## **SN5472, SN54H72, SN54L72, SN7472, SN74H72**

### ***AND-Gated J-K Master-Slave Flip-Flops with Preset and Clear***

These J-K flip-flops are based on the master-slave principle and each has AND gate inputs for entry into the master section which are controlled by the clock pulse. The clock pulse also regulates the state of the coupling transistors which connect the master and slave sections. Logical state of J and K inputs must not be allowed to change when the clock pulse is in a high state. The SN5472, SN54H72, and the SN54L72 are characterized for operation over the full military temperature range of -55°C to 125°C while the SN7472 and the SN74H72 are characterized for operation from 0°C to 70°C.

#### **Rochester Electronics Manufactured Components**

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

#### **Quality Overview**

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
  - Class Q Military
  - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
  - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

*The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.*

# TYPES SN5472, SN54H72, SN54L72, SN7472, SN74H72 AND-GATED J-K MASTER-SLAVE FLIP-FLOPS WITH PRESET AND CLEAR

REVISED DECEMBER 1983

- Package Options Include Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

## description

These J-K flip-flops are based on the master-slave principle and each has AND gate inputs for entry into the master section which are controlled by the clock pulse. The clock pulse also regulates the state of the coupling transistors which connect the master and slave sections. The sequence of operation is as follows:

1. Isolate slave from master
2. Enter information from AND gate inputs to master
3. Disable AND gate inputs
4. Transfer information from master to slave

Logical state of J and K inputs must not be allowed to change when the clock pulse is in a high state.

The SN5472, SN54H72, and the SN54L72 are characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN7472 and the SN74H72 are characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

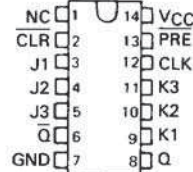
FUNCTION TABLE

INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	$\bar{Q}$
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H <sup>†</sup>	H <sup>†</sup>
H	H	$\downarrow$	L	L	Q <sub>0</sub>	$\bar{Q}_0$
H	H	$\downarrow$	H	L	H	L
H	H	$\downarrow$	L	H	L	H
H	H	$\downarrow$	H	H	TOGGLE	TOGGLE

<sup>†</sup> This configuration is nonstable; that is, it will not persist when either preset or clear returns to its inactive (high) level.

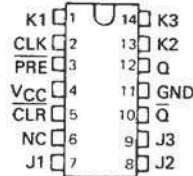
SN5472, SN54H72, SN54L72 . . . J PACKAGE  
SN7472, SN74H72 . . . J OR N PACKAGE

(TOP VIEW)



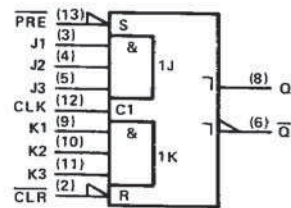
SN5472, SN54H72 . . . W PACKAGE

(TOP VIEW)



NC - No internal connection

## logic symbol



Pin numbers shown are for J and N packages.

## positive logic

$$J = J1 \cdot J2 \cdot J3$$

$$K = K1 \cdot K2 \cdot K3$$

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TTL DEVICES

**PRODUCTION DATA**  
This document contains information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

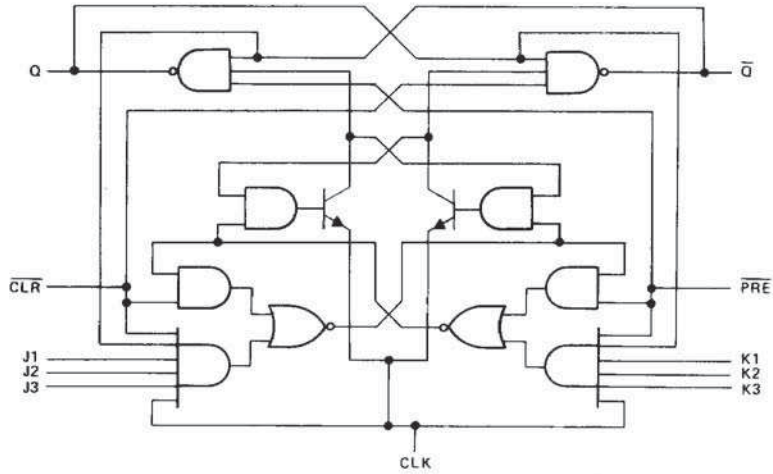
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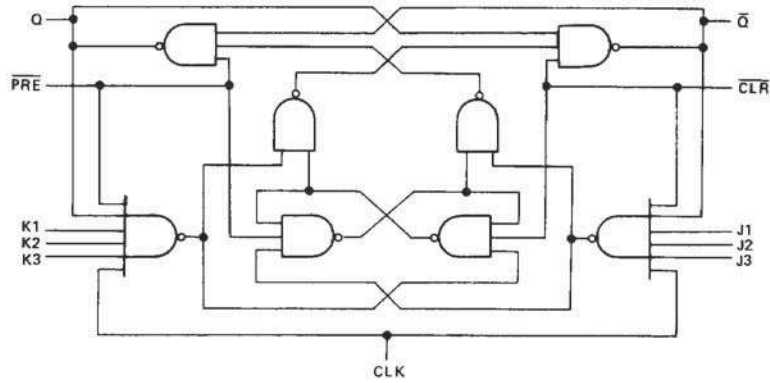
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TYPES SN5472, SN54H72, SN54L72,  
 SN7472, SN74H72  
 AND-GATED J-K MASTER-SLAVE FLIP-FLOPS WITH PRESET AND CLEAR

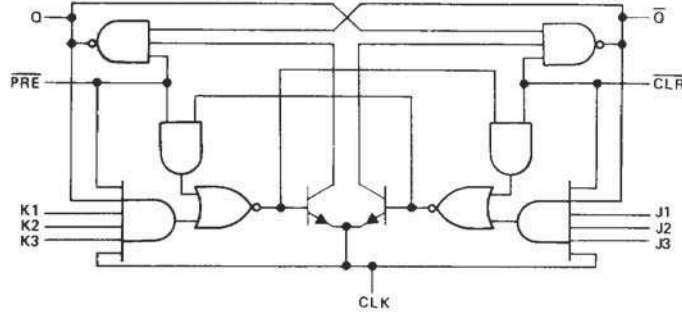
logic diagrams  
 72



'H72



'L72



**3** TTL DEVICES



**TYPES SN5472, SN7472**  
**AND-GATED J-K MASTER-SLAVE FLIP-FLOPS WITH PRESET AND CLEAR**

**recommended operating conditions**

		SN5472			SN7472			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage	0.8			0.8			V
I <sub>OH</sub>	High-level output current	-0.4			-0.4			mA
I <sub>OL</sub>	Low-level output current	16			16			mA
t <sub>w</sub>	Pulse duration	CLK high	20		20		ns	
		CLK low	47		47			
		PRE or CLR	25		25			
t <sub>su</sub>	Input setup time before CLK ↑	0			0			ns
t <sub>h</sub>	Input hold time data after CLK ↓	0			0			ns
T <sub>A</sub>	Operating free-air temperature	-55	125		0	70		°C

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS †	SN5472			SN7472			UNIT
		MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V <sub>IK</sub>	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA	-1.5			-1.5			V
V <sub>OH</sub>	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -0.4 mA	2.4	3.4		2.4	3.4		V
V <sub>OL</sub>	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 16 mA		0.2	0.4		0.2	0.4	V
I <sub>I</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V	1			1			mA
I <sub>IH</sub>	J or K	40			40			μA
	All other	80			80			
I <sub>IL</sub>	J or K	-1.6			-1.6			mA
	All other	-3.2			-3.2			
I <sub>OS</sub> §	V <sub>CC</sub> = MAX	-20	-57		-18	-57		mA
I <sub>CC</sub>	V <sub>CC</sub> = MAX, See Note 2	10	20		10	20		mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time.

NOTE 2: With all outputs open, I<sub>CC</sub> is measured with the Q and  $\bar{Q}$  outputs high in turn. At the time of measurement, the clock input is grounded.

**switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C (see note 3)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f <sub>max</sub>				15	20		MHz
†P <sub>LH</sub>	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$	Q or $\bar{Q}$	R <sub>L</sub> = 400 Ω, C <sub>L</sub> = 15 pF	16	25		ns
†P <sub>HL</sub>				25	40		ns
†P <sub>LH</sub>	CLK	Q or $\bar{Q}$		16	25		ns
†P <sub>HL</sub>				25	40		ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

**3** TTL DEVICES

**TYPES SN54H72, SN74H72**  
**AND-GATED J-K MASTER-SLAVE FLIP-FLOPS WITH PRESET AND CLEAR**

**recommended operating conditions**

		SN54H72			SN74H72			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage				0.8			V
I <sub>OH</sub>	High-level output current				-0.5			mA
I <sub>OL</sub>	Low-level output current				20			mA
t <sub>w</sub>	Pulse duration	CLK high	12		12		ns	
		CLK low	28		28			
		CLR or PRE	16		16			
t <sub>su</sub>	Setup time, before CLK ↑	data high or low		0		ns		
t <sub>h</sub>	Hold time-data after CLK ↓	0		0		ns		
T <sub>A</sub>	Operating free-air temperature	-55	125	0	70	°C		

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS †	SN54H72		SN74H72		UNIT
		MIN	TYP‡	MAX	MIN	
V <sub>IK</sub>	V <sub>CC</sub> = MIN, I <sub>I</sub> = -8 mA			-1.5		V
V <sub>OH</sub>	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -0.5 mA	2.4	3.4	2.4	3.4	V
V <sub>OL</sub>	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 20 mA	0.2 0.4		0.2 0.4		V
I <sub>I</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V	1		1		mA
I <sub>IH</sub>	J, K or CLK	50		50		μA
	PRE or CLR*	100		100		
I <sub>IL</sub>	J, K or CLR	-2		-2		mA
	PRE or CLR*	-4		-4		
I <sub>OS</sub> §	V <sub>CC</sub> = MAX	-40	-100	-40	-100	mA
I <sub>CC</sub>	V <sub>CC</sub> = MAX, See Note 2	16	25	16	25	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.  
‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.  
§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.  
\* Clear is tested with preset high and preset is tested with clear high.  
NOTE 2: With all outputs open, I<sub>CC</sub> is measured with the Q and Q̄ outputs high in turn. At the time of measurement, the clock input is grounded.

**switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C (see note 3)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f <sub>max</sub>			R <sub>L</sub> = 280 Ω, C <sub>L</sub> = 25 pF	25	30		MHz
t <sub>PLH</sub>	PRE or CLR	Q or Q̄		6	13		ns
t <sub>PHL</sub>				12	24		ns
t <sub>PLH</sub>	CLK	Q or Q̄		14	21		ns
t <sub>PHL</sub>				22	27		ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

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**TTL DEVICES**

**TYPE SN54L72**  
**AND-GATED J-K MASTER-SLAVE FLIP-FLOPS WITH PRESET AND CLEAR**

**recommended operating conditions**

		MIN	NOM	MAX	UNIT
$V_{CC}$	Supply voltage	4.5	5	5.5	V
$V_{IH}$	High-level input voltage	2			V
$V_{IL}$	Low-level input voltage			0.6	V
				0.7	
$I_{OH}$	High-level output current			-0.1	mA
$I_{OL}$	Low-level output current			2	mA
$t_w$	Pulse duration			200	ns
				100	
$t_{su}$	Setup time before CLK $\uparrow$	0			ns
$t_h$	Hold time, data after CLK $\downarrow$	0			ns
$T_A$	Operating free-air temperature	-55		125	$^{\circ}$ C

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS $\dagger$	MIN	TYP $\ddagger$	MAX	UNIT
$V_{OH}$	$V_{CC} = \text{MIN}$ , $V_{IH} = 2 \text{ V}$ , $V_{IL} = \text{MAX}$ , $I_{OH} = -0.1 \text{ mA}$	2.4	3.3		V
$V_{OL}$	$V_{CC} = \text{MIN}$ , $V_{IH} = 2 \text{ V}$ , $V_{IL} = \text{MAX}$ , $I_{OL} = 2 \text{ mA}$		0.15	0.3	V
$I_I$	J or K	$V_{CC} = \text{MAX}$ , $V_I = 5.5 \text{ V}$		0.1	mA
	All other			0.2	
$I_{IH}$	J or K	$V_{CC} = \text{MAX}$ , $V_I = 2.4 \text{ V}$		10	$\mu$ A
	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$			20	
	CLK			-200	
$I_{IL}$	J or K	$V_{CC} = \text{MAX}$ , $V_I = 0.3 \text{ V}$		-0.18	mA
	All other			-0.36	
$I_{OS}$	$V_{CC} = \text{MAX}$	-3		-15	mA
$I_{CC}$	$V_{CC} = \text{MAX}$ , See Note 2		0.76	1.44	mA

$\dagger$  For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

$\ddagger$  All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

NOTE 2: With all outputs open,  $I_{CC}$  is measured with the Q and  $\overline{\text{Q}}$  outputs high in turn. At the time of measurement, the clock input is grounded.

**switching characteristics,  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$  (see note 3)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{max}$				2.5	3		MHz
$t_{PLH}$	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$	Q or $\overline{\text{Q}}$	$R_L = 4 \text{ k}\Omega$ , $C_L = 50 \text{ pF}$		35	75	ns
$t_{PHL}$	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ (CLK high)	$\overline{\text{Q}}$ or Q			60	150	ns
	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ (CLK low)					200	
$t_{PLH}$	CLK	Q or $\overline{\text{Q}}$			10	35	75
$t_{PHL}$				10	60	150	ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.